

**Notice of References Cited**

Application/Control No.

10/032,787

Applicant(s)/Patent Under Reexam

China et al

Examiner

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Art Unit

1617

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	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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